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MX 3083.1  
PATENT

G. H. DeWitt  
JUL 1 2002  
9-3-02

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Application of Youqi Wang, et al.  
Serial No. 09/652,489  
Filed August 31, 2000  
Confirmation No. 3644  
For SAMPLING PROBE  
Examiner Elizabeth S. Quan

Art Unit 2899

June 21, 2002

AMENDMENT B

TO THE ASSISTANT COMMISSIONER FOR PATENTS,  
Washington, D.C. 20231

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TC 1700

SIR:

In response to the Office action dated May 21, 2002,  
please amend the above-identified application as follows:

In the Claims:

27. (amended) A probe as set forth in claim 26 wherein  
the vent passage inlet is positioned adjacent the tip for  
removing reactant from an area outside the recess.

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